Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/690,587	SEKINE ET AL.	
Examiner	Art Unit	
HoangAnh T. Le	2821	

	SEARCHED			
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
FAST	2/18/02	#/6		
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